

Notice of References Cited	Application/Control No. 09/989,265	Applicant(s)/Patent Under Reexamination LO ET AL.	
	Examiner Gregory B. Sefcheck	Art Unit 2662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0033840 A1	02-2005	Nisani et al.	709/224
*	B	US-2004/0037317 A1	02-2004	Zalitzky et al.	370/466
*	C	US-2002/0106029 A1	08-2002	Bunn et al.	375/257
*	D	US-2002/0083205 A1	06-2002	Leon et al.	709/247
*	E	US-6,925,092 B1	08-2005	Derks et al.	370/465
*	F	US-6,801,530 B1	10-2004	Brandt et al.	370/392
*	G	US-6,584,509 B2	06-2003	Putzolu, David M.	709/240
*	H	US-6,480,892 B1	11-2002	Levay et al.	709/224
*	I	US-6,456,967 B1	09-2002	Yeom, Eung-Moon	704/220
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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